THIS REVISION DESCRIBED	Form Approved OMB No. 0704-0188				
Public reporting burden for this collection is gathering and maintaining the data needed, aspect of this collection of information, inn for Information Operations and Report	2. PROCURING ACTIVITY NO.				
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4. ORIGINATOR	b. ADDRESS ( Defense Elec	Street, City, State, Zip	Code)	5. CAGE CODE 67268	6. NOR NO. 5962-R177-96
a. TYPED NAME (First, Middle Last)	Initial, Dayton, OH 4	gton Pike 15444-5765		7. CAGE CODE 67268	8. DOCUMENT NO. 5962-86887
9. TITLE OF DOCUMENT MICROCIRCUIT, LINEAR, LO	OW NOISE OPERATIONAL	AMPLIFIER,	10. REVISION LETT	ER	11. ECP NO.
MONOLITHIC SILICON			a. CURRENT	b. NEW A	N/A
12. CONFIGURATION ITEM (C All	OR SYSTEM) TO WHICH EC	CP APPLIES	1	1	
13. DESCRIPTION OF REVISI	ON				
Sheet 1: Revisions for column Revisions description Revision level block Rev status of pages On page 1, at the bo add "CURRENT CA	n; add "A". n column; add "Changes in a mn; add "96-07-10". ; add "A". ; for page 1, add "A". ottom of the open area betwee AGE CODE 67268".	accordance with NOR 5	5962-R117-96".	s block	
14. THIS SECTION FOR GOV	ERNMENT USE ONLY				
a. <i>(X one)</i> X (1) Exi	sting document supplemente	d by the NOR may be	used in manufacture.		
(2) Re	vised document must be rece	eived before manufactu	rer may incorporate this	s change.	
(3) Custodian of master document shall make above revision and furnish revised document.					
b. ACTIVITY AUTHORIZED TO	O APPROVE CHANGE FOR	GOVERNMENT	c. TYPED NAME (Fin	rst, Middle Initial, Last)	
DESC-ELD		T	Michael A. Frye		
d. TITLE		e. SIGNATURE			f. DATE SIGNED (YYMMDD)
Chief, Microelectronics Branch	h	Michael A. Frye			96-07-10
15a. ACTIVITY ACCOMPLISH	NG REVISION	b. REVISION COMP	C. DATE SIGNED (Signature) C. DATE SIGNED (YYMMDD)		
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1. SCOPE						
1.1 <u>Scope</u> . This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".						
1.2 Part number. The complete part number shall be as show	n in the following example:					
<u>5962-86887</u> <u>01</u> <u>C</u>	X					
Drawing number Device type Case out (1.2.1) (1.2.2)	line Lead finish per MIL-M-38510					
1.2.1 <u>Device type</u> . The device type shall identify the circuit fund	ction as follows:					
Device type Generic number	Circuit function					
01 OP-227A	Dual, low-offset, low noise operational amplifier					
1.2.2 <u>Case outline</u> . The case outline shall be as designated in	appendix C of MIL-M-38510, and as follows:					
Outline letter Case outline						
C D-1 (14-lead, 1/4" x 3/4"), dual-in-li	ne package					
1.3 Absolute maximum ratings. 1/						
Supply voltage ( $V_{CC}$ )						
1.4 Recommended operating conditions.						
Supply voltage (V <sub>CC</sub> )						
<ul> <li><u>1</u>/ Unless otherwise specified, all voltages are referenced to ground.</li> <li><u>2</u>/ The inputs are protected by back-to-back diodes. Current limiting resistors are not used in order to achieve low noise. If differential input voltage exceeds ±0.7 V, the input current should be limited to 25 mA.</li> <li><u>3</u>/ For T<sub>A</sub> greater than 106° C, derate linearly at 11.3 mW/° C.</li> </ul>						
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#### 2. APPLICABLE DOCUMENTS

2.1 <u>Government specification and standard</u>. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 <u>Order of precedence</u>. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

## 3. REQUIREMENTS

3.1 <u>Item requirements</u>. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.

3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.

3.2.1 Terminal connections and logic diagram. The terminal connections and logic diagram shall be as specified on figure 1.

3.2.2 <u>Case outline</u>. The case outline shall be in accordance with 1.2.2 herein.

3.3 <u>Electrical performance characteristics</u>. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full recommended ambient operating temperature range.

3.4 <u>Marking</u>. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.

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Test	Symbol	Conditions -55° C $\leq$ T <sub>A</sub> $\leq$ +125° C		ol Conditions -55° C $\leq T_A \leq +125°$ C		Group A subgroups	Lin	nits	Unit
		±V <sub>S</sub> = (unless other	= ±15 V wise specified)		Min	Max			
Input offset voltage	V <sub>IO</sub>			1		80	μV		
				2, 3		180			
Input offset current	I <sub>IO</sub>			1		35	nA		
				2, 3		50			
Input bias current	I <sub>IB</sub>			1		40	]		
				2, 3		60			
Average input offset drift <u>1</u> /	TC V <sub>IO</sub>			1, 2, 3		1.0	µV/° C		
Power supply rejection ratio	PSRR	$V_{S} = \pm 4$ to $\pm 18$ V		1		10	μV/V		
				2, 3		16	Ī		
Common mode rejection CMRR $V_{CM} = \pm 11 V$			1	114		dB			
ratio		$V_{CM} = \pm 10 V$		2, 3	108		Ī		
Large signal voltage gain	A <sub>VOL</sub>	$V_0 = \pm 10 \text{ V}; \text{ R}_1 \ge 2 \text{ kilohms}$		4	1000		V/mV		
		$V_0 = \pm 10 \text{ V}; \text{ R}_L \ge 60$	0 ohms	4	800				
Input voltage range	IVR	$T_A = 25^{\circ}C$		1	±11.0		V		
		$T_{A} = -55^{\circ}C, +125^{\circ}C$	<u>1</u> /	2, 3	±10.0		]		
Output voltage swing	V <sub>OP</sub>	$R_L \ge 2$ kilohms		4	±12				
				5, 6	±11.5				
		$R_L \ge 600 \text{ ohms}$		4	±10				
Slew rate	SR		$R_L \ge 2$ kilohms	7	1.7		V/µs		
Input noise voltage density	En	$T_A = 25^{\circ}C$	f <sub>o</sub> = 10 Hz	7		6.0	<u>nV</u>		
			f <sub>o</sub> = 1,000 Hz			3.9	, T T Z		
See footnote at end of table.									
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	TABL	E I. Electrical performanc	<u>e characteristics</u> - C	Continued.					
Test	Symbol	Conditions <u>1/</u> -55°C < T < +125°C		bol Conditions $\frac{1}{-55^{\circ}C} < T_{A} < +125^{\circ}C$		Group A subgroups	Lin	nits	Unit
		±V <sub>S</sub> = ±1 (unless otherwise	5 V e specified)		Min	Max			
Input noise current density	I <sub>n</sub>	$f_0 = 10 \text{ Hz}, \text{ T}_A = 25^{\circ} \text{ C}$		7		5.66	<u>pA_</u>		
		f <sub>o</sub> = 1,000 Hz, T <sub>A</sub> = 25° C	)			0.99	۷HZ		
Gain-bandwidth product <u>1</u> /	GBW	f = 100 kHz, T <sub>A</sub> = 25° C		4	5.0		MHz		
Power consumption	P <sub>D</sub>	Each amplifier, $T_A = 25^{\circ}$	1		140	mW			
Input offset voltage match	V <sub>OS</sub>	$T_A = 25^{\circ}C$		1		80	μV		
		T <sub>A</sub> = -55°C, +125°C		2, 3		180			
Average noninverting bias current	I <sub>B</sub> +	<sub>B</sub> + =   <sub>B+A</sub> +   <sub>B+B</sub>	$T_A = 25^{\circ}C$	1		±40	nA		
		2	T <sub>A</sub> = -55° C, T <sub>A</sub> = 125° C	2, 3		±60			
Noninverting offset current	I <sub>OS+</sub>	I <sub>OS+</sub> =	$T_A = 25^{\circ}C$	1		±60			
	I <sub>B+A</sub> - I <sub>B+B</sub>	<sup>I</sup> B+A <sup>-</sup> <sup>I</sup> B+B	$T_A = -55^{\circ} C,$ $T_A = 125^{\circ} C$	2, 3		±90			
Inverting offset current	I <sub>OS-</sub>	I <sub>OS-</sub> =	T <sub>A</sub> = 25°C	1		±60			
I <sub>B-A</sub> - I <sub>B-B</sub>		<sup>I</sup> B-A <sup>- I</sup> B-B	T <sub>A</sub> = -55° C, T <sub>A</sub> = 125° C	2, 3		±90			

<u>1</u>/ Guaranteed if not tested.

3.5 <u>Certificate of compliance</u>. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.

3.6 <u>Certificate of conformance</u>. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

3.7 <u>Notification of change</u>. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).

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3.8 <u>Verification and review</u>. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

# 4. QUALITY ASSURANCE PROVISIONS

4.1 <u>Sampling and inspection</u>. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).

4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

- a. Burn-in test (method 1015 of MIL-STD-883).
  - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
  - (2)  $T_A = +125^{\circ}C$ , minimum.
- b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 <u>Quality conformance inspection</u>. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

4.3.1 Group A inspection.

- a. Tests shall be as specified in table II herein.
- b. Subgroups 8, 9, 10, and 11 in table I, method 5005 of MIL-STD-883 shall be omitted.

## 4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test (method 1005 of MIL-STD-883) conditions:
  - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
  - (2)  $T_A = +125^{\circ}C$ , minimum.
  - (3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

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MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	1
Final electrical test parameters (method 5004)	1*, 2, 3, 4
Group A test requirements (method 5005)	1, 2, 3, 4, 5, 6, 7
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3
Additional electrical subgroups for group C periodic inspections	

# TABLE II. Electrical test requirements.

\* PDA applies to subgroup 1.

# 5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

6.2 <u>Replaceability</u>. Replaceability is determined as follows:

- a. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- b. When a QPL source is established, the part numbered device specified in this drawing will be replaced by the microcircuit identified as part number M38510/13504BCX.

6.3 <u>Comments</u>. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

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6.4 <u>Approved source of supply</u>. Approved sources of supply are listed herein. Additional sources will be added as they become available. The vendors listed herein have agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor	Vendor <u>1</u> /	Replacement
	CAGE	similar part	military specification
	number	number	part number
5962-8688701CX	64155 54186 06665	OP-227AJ/883B MP OP-227AY OP-227A883	M38510/13504BCX

1/ <u>Caution</u>. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number	Vendor name and address
64155	Linear Technology, Inc. 1630 McCarthy Blvd. Milpitas, CA 95035-7487
54186	Micro Power Systems, Inc. 3100 Alfred Street Santa Clara, CA 95050-3674
06665	Precision Monolithic, Inc. 1500 Space Park Drive P.O. Box 58020 Santa Clara, CA 95050

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